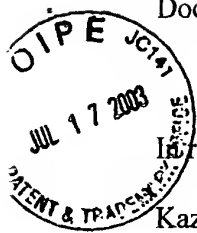


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Docket No. WAK.059

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Kazuki Yokota

Serial No.: 09/627,456 ✓

Group Art Unit: 2851 ✓

Filed: July 27, 2000

Examiner: Cruz, Magda

For: OVERLAY MARK, METHOD OF MEASURING OVERLAY ACCURACY,  
METHOD OF MAKING ALIGNMENT AND SEMICONDUCTOR DEVICE  
THEREWITH

Honorable Commissioner of Patents  
Alexandria, Virginia 22313-1450

**EXCESS CLAIM FEE PAYMENT LETTER**

Sir:

Transmitted herewith is an amendment in the above-identified application. The fee has been calculated and is transmitted as shown below.

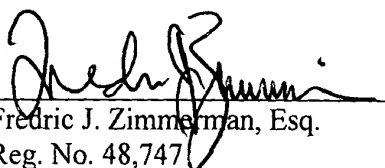
	<u>AFTER AMENDMENT</u>	<u>PREV. PAID FOR</u>	<u>EXTRA CLAIMS PRESENT</u>	<u>RATE</u>	<u>FEE DUE</u>
Total Claims	27 -	21	= 6	x \$18.00	\$ 108.00
Indep. Claims	3 -	3	= 1	x \$84.00	\$ -
<b>TOTAL ADDITIONAL FEE FOR THIS AMENDMENT</b>					<b>\$ 108.00</b>

A check in the amount of \$108.00 is submitted herewith to cover the excess claim fees. A duplicate copy of this sheet is enclosed. The Commissioner is authorized to charge any deficiencies in fees and credit any overpayment of fees to Attorney's Deposit Account No. 50-0481.

Respectfully Submitted,

Date:

7/17/03

  
Fredric J. Zimmerman, Esq.  
Reg. No. 48,747

**McGinn & Gibb, PLLC**  
8321 Old Courthouse Road, Suite 200  
Vienna, VA 22182  
(703) 761-4100  
Customer No.: 21254

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Re Application of

Kazuki Yokota

Serial No.: 09/627,456

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Filed: July 27, 2000

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THEREWITH

Honorable Commissioner of Patents  
Alexandria, Virginia 22313-1450

**AMENDMENT UNDER 37 C.F.R. §1.111**

Sir:

In response to the Office Action dated **April 23, 2003**, please amend the above-  
identified application as follows:

07/18/2003 RUCNDRAF1 00000086 09627456

01 FC:1202

108.00 OP

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